

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10575775	DANIEL, RON
	<b>Examiner</b>	<b>Art Unit</b>
	SHEELA C CHAWAN	2624

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
382	103,206,203,291,218,199, 217,144	2/28/09	SCC
356	394,622,607	"	"
353	122,28	"	"
378	8,16,108	"	"
250	234,559.24, 559.06,559.06,559.22,559.19	"	"
701	209	"	"

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
SEARCH EAST AND OTHER DATA BASE, SEE THE SEARCH HISTORY.	2/28/09	SCC
SEARCH INVENTOR NAME	"	"
SEARCH IEEE OR INSPEC DATA BASE.	"	"

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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